

Source	HWElectron category	HWTIS category
Simulation sample statistics	0.06	0.05
Trigger efficiency	0.07	-
PID efficiency	0.08	0.10
Fit procedure	+0.09 -0.22	+0.07 -0.23
$B^0 \rightarrow K^{*0} \gamma$ contamination	0.08	0.08
Total	+0.17 -0.26	+0.16 -0.27